

# VBFB165R08S Datasheet

## N-Channel 650V (D-S) Super Junction Power MOSFET



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

| PRODUCT SUMMARY                         |                 |       |
|---|-----------------|-------|
| $V_{DS}$ (V) at $T_J$ max.              | 650             |       |
| $R_{DS(on)}$ typ. ( $\Omega$ ) at 25 °C | $V_{GS} = 10$ V | 0.550 |

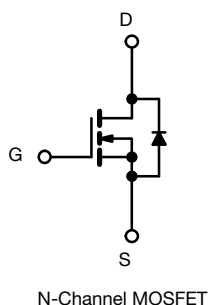
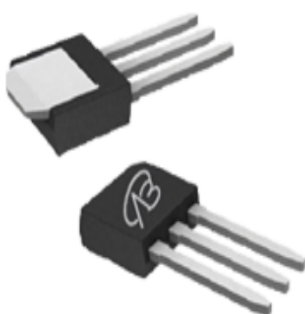
### FEATURES

- Low figure-of-merit (FOM)  $R_{on} \times Q_g$
- Low input capacitance ( $C_{iss}$ )
- Reduced switching and conduction losses
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)

### APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

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| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted) |                         |                         |                                   |             |      |
|---|-------------------------|-------------------------|-----------------------------------|-------------|------|
| PARAMETER   |                         |                         | SYMBOL                            | LIMIT       | UNIT |
| Drain-source voltage  |                         |                         | V <sub>DS</sub>                   | 650         | V    |
| Gate-source voltage   |                         |                         | V <sub>GS</sub>                   | ± 30        |      |
| Continuous drain current (T <sub>J</sub> = 150 °C)                        | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  | I <sub>D</sub>                    | 8           | A    |
|   |                         | T <sub>C</sub> = 100 °C |                                   | 5           |      |
| Pulsed drain current <sup>a</sup>   |                         |                         | I <sub>DM</sub>                   | 24          |      |
| Linear derating factor  |                         |                         |                                   | 1.7         | W/°C |
| Single pulse avalanche energy <sup>b</sup>                                |                         |                         | E <sub>AS</sub>                   | 185         | mJ   |
| Maximum power dissipation   |                         |                         | P <sub>D</sub>                    | 128         | W    |
| Operating junction and storage temperature range                          |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C   |
| Drain-source voltage slope  | T <sub>J</sub> = 125 °C |                         | dV/dt                             | 50          | V/ns |
| Reverse diode dV/dt <sup>d</sup>  |                         |                         |                                   | 5.1         |      |
| Soldering recommendations (peak temperature) <sup>c</sup>                 | For 10 s                |                         |                                   | 260         | °C   |


### Notes

- Repetitive rating; pulse width limited by maximum junction temperature
- $V_{DD} = 100$  V, starting  $T_J = 25$  °C,  $L = 30$  mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 8.0$  A
- 1.6 mm from case
- $I_{SD} \leq I_D$ ,  $dI/dt = 100$  A/ $\mu$ s, starting  $T_J = 25$  °C

**THERMAL RESISTANCE RATINGS**

| PARAMETER                        | SYMBOL     | TYP. | MAX. | UNIT |
|----------------------------------|------------|------|------|------|
| Maximum junction-to-ambient      | $R_{thJA}$ | -    | 62   | °C/W |
| Maximum junction-to-case (drain) | $R_{thJC}$ | -    | 0.65 |      |

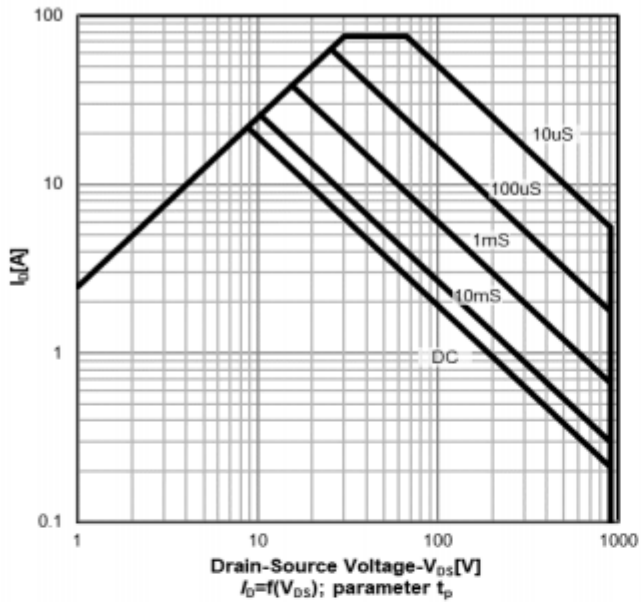
**SPECIFICATIONS** ( $T_J = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted)

| PARAMETER   | SYMBOL              | TEST CONDITIONS  |  | MIN. | TYP.  | MAX.      | UNIT                  |
|---|---------------------|--|--|------|-------|-----------|-----------------------|
| Static  |                     |  |  |      |       |           |                       |
| Drain-source breakdown voltage                            | $V_{DS}$            | $V_{GS} = 0\text{ V}$ , $I_D = 250\text{ }\mu\text{A}$   |  | 650  | -     | -         | V                     |
| $V_{DS}$ temperature coefficient                          | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^{\circ}\text{C}$ , $I_D = 1\text{ mA}$  |  | -    | 1.08  | -         | V/ $^{\circ}\text{C}$ |
| Gate-source threshold Voltage (N)                         | $V_{GS(th)}$        | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$   |  | 2.0  | -     | 4.0       | V                     |
| Gate-source leakage                                       | $I_{GSS}$           | $V_{GS} = \pm 20\text{ V}$   |  | -    | -     | $\pm 100$ | nA                    |
|   |                     | $V_{GS} = \pm 30\text{ V}$   |  | -    | -     | $\pm 1$   | $\mu\text{A}$         |
| Zero gate voltage drain current                           | $I_{DSS}$           | $V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$  |  | -    | -     | 1         | $\mu\text{A}$         |
|   |                     | $V_{DS} = 520\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 125\text{ }^{\circ}\text{C}$  |  | -    | -     | 10        |                       |
| Drain-source on-state resistance                          | $R_{DS(on)}$        | $V_{GS} = 10\text{ V}$   | $I_D = 2.5\text{ A}$                         | -    | 0.550 | -         | $\Omega$              |
| Forward transconductance                                  | $g_{fs}$            | $V_{DS} = 30\text{ V}$ , $I_D = 2.5\text{ A}$  |  | -    | 8.7   | -         | S                     |
| Dynamic   |                     |  |  |      |       |           |                       |
| Input capacitance   | $C_{iss}$           | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 100\text{ V}$ ,<br>$f = 1\text{ MHz}$   |  | -    | 2600  | -         | pF                    |
| Output capacitance  | $C_{oss}$           |  |  | -    | 81    | -         |                       |
| Reverse transfer capacitance                              | $C_{rss}$           |  |  | -    | 9     | -         |                       |
| Effective output capacitance, energy related <sup>a</sup> | $C_{O(er)}$         | $V_{DS} = 0\text{ V to } 480\text{ V}$ , $V_{GS} = 0\text{ V}$   |  | -    | 58    | -         |                       |
| Effective output capacitance, time related <sup>b</sup>   | $C_{O(tr)}$         |  |  | -    | 296   | -         |                       |
| Total gate charge   | $Q_g$               | $V_{GS} = 10\text{ V}$   | $I_D = 5\text{ A}$ , $V_{DS} = 480\text{ V}$ | -    | 40    | 122       | nC                    |
| Gate-source charge  | $Q_{gs}$            |  |  | -    | 16    | -         |                       |
| Gate-drain charge   | $Q_{gd}$            |  |  | -    | 20    | -         |                       |
| Turn-on delay time  | $t_{d(on)}$         | $V_{DD} = 480\text{ V}$ , $I_D = 5\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ , $R_g = 9.1\text{ }\Omega$   |  | -    | 22    | 44        | ns                    |
| Rise time   | $t_r$               |  |  | -    | 24    | 48        |                       |
| Turn-off delay time                                       | $t_{d(off)}$        |  |  | -    | 71    | 142       |                       |
| Fall time   | $t_f$               |  |  | -    | 26    | 52        |                       |
| Gate input resistance                                     | $R_g$               | $f = 1\text{ MHz}$ , open drain  |  | 0.3  | 0.7   | 1.4       | $\Omega$              |
| Drain-Source Body Diode Characteristics                   |                     |  |  |      |       |           |                       |
| Continuous source-drain diode current                     | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode<br> |  | -    | -     | 8         | A                     |
| Pulsed diode forward current                              | $I_{SM}$            |  |  | -    | -     | 24        |                       |
| Diode forward voltage                                     | $V_{SD}$            | $T_J = 25\text{ }^{\circ}\text{C}$ , $I_S = 5\text{ A}$ , $V_{GS} = 0\text{ V}$  |  | -    | -     | 1.2       | V                     |
| Reverse recovery time                                     | $t_{rr}$            | $T_J = 25\text{ }^{\circ}\text{C}$ , $I_F = I_S = 5\text{ A}$ ,<br>$dI/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 25\text{ V}$                              |  | -    | 66    | 132       | ns                    |
| Reverse recovery charge                                   | $Q_{rr}$            |  |  | -    | 6.4   | 12.8      | $\mu\text{C}$         |
| Reverse recovery current                                  | $I_{RRM}$           |  |  | -    | 27    | -         | A                     |

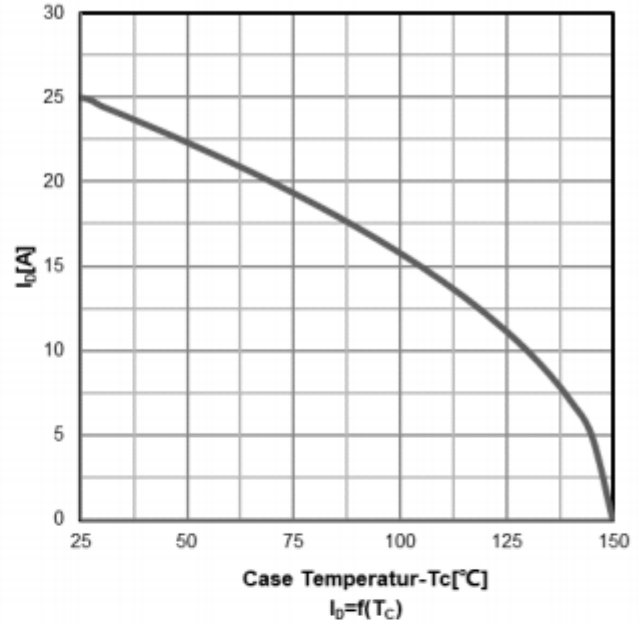
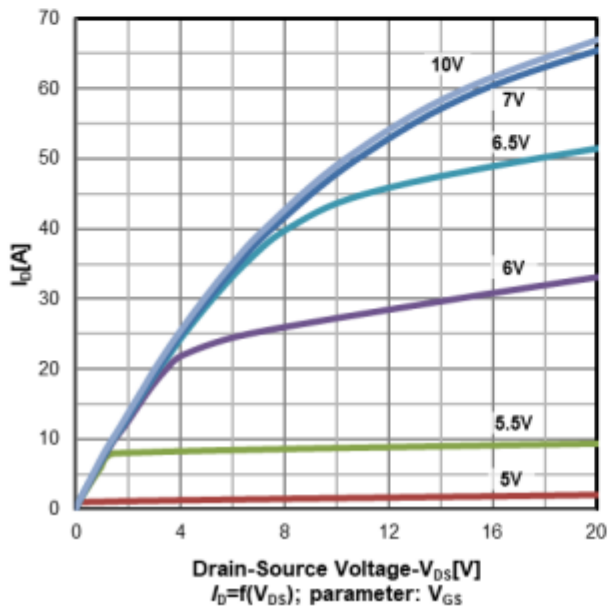
**Notes**

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$   
 b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$

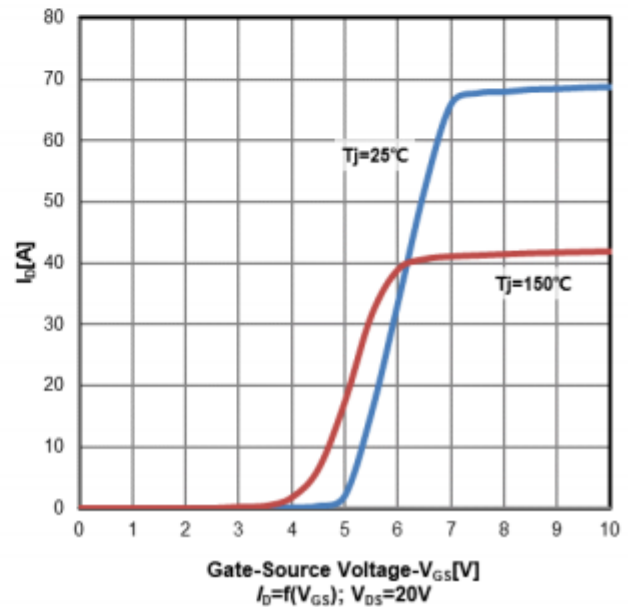
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

 Safe operating area TC=25 °C  
 Non FullPAK


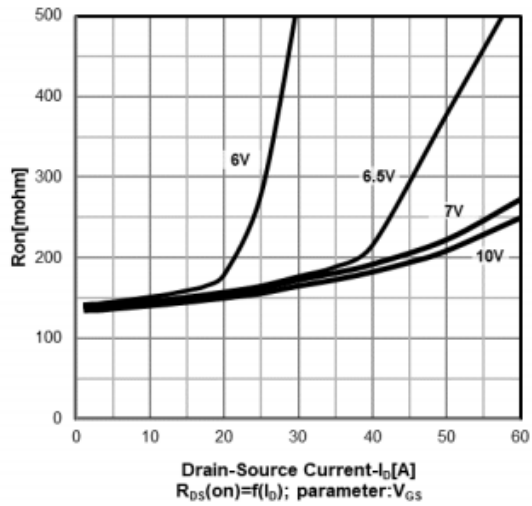
Drain current vs temperature


 Typ. output characteristics  $T_J=25\text{ °C}$ 


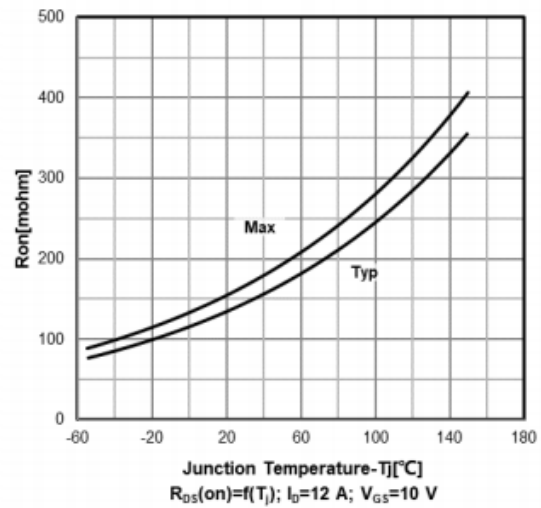
Typ. transfer characteristics



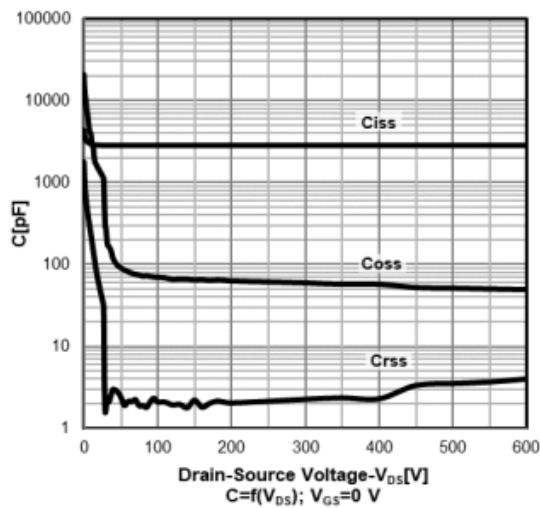
Typ. drain-source on-state resistance



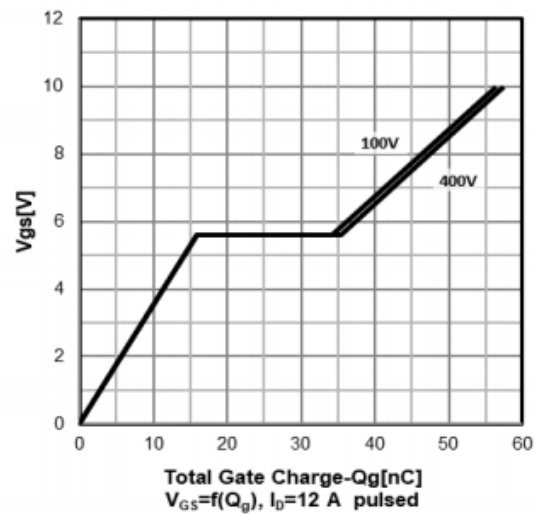
On resistance vs temperature



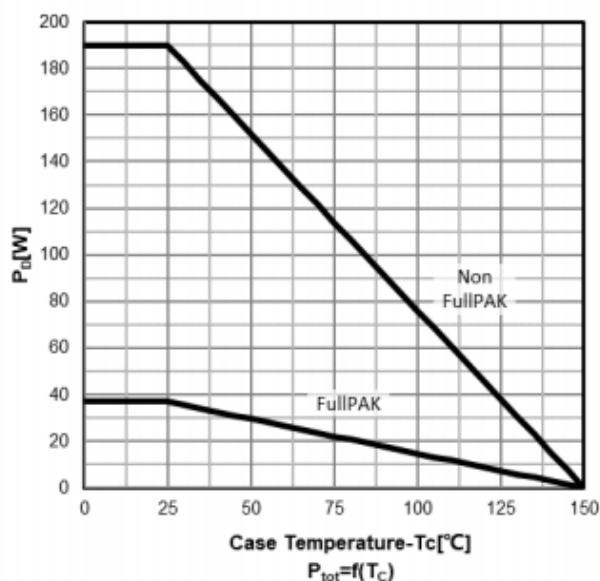
Typ. capacitances



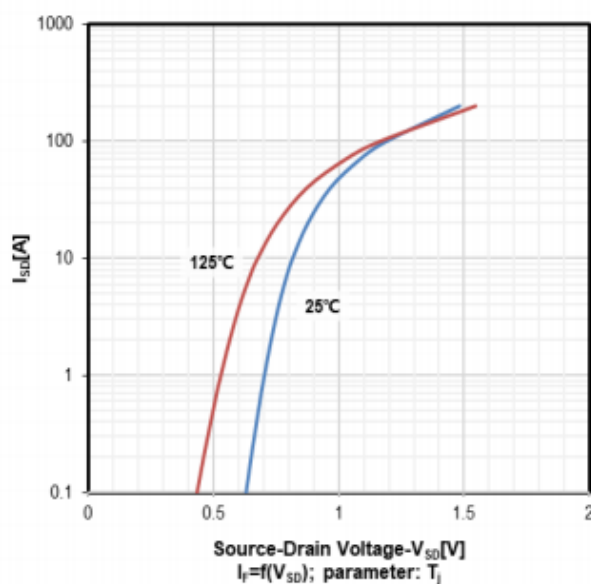
Typ. gate charge characteristics



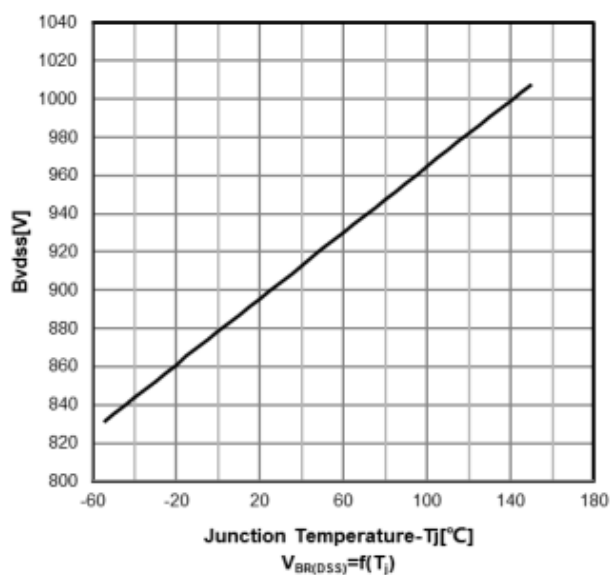
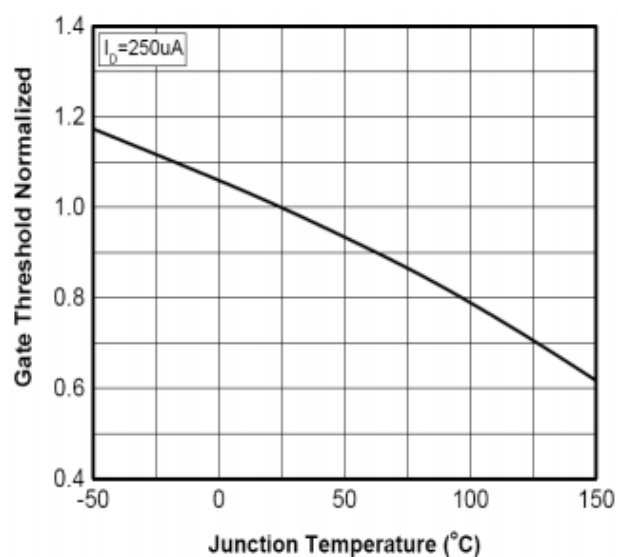
Power dissipation



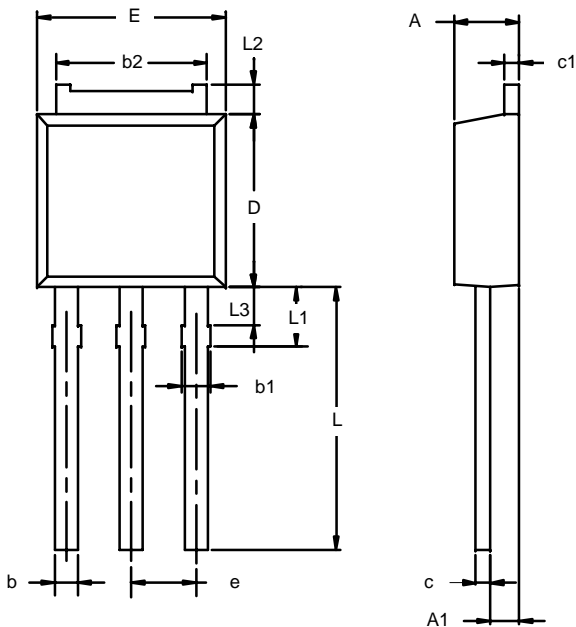
Forward characteristics of reverse diode



Drain-source breakdown voltage

Normalized  $V_{GS(th)}$  characteristics

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Note: Dimension L3 is for reference only.

| Dim | MILLIMETERS |      | INCHES    |       |
|-----|-------------|------|-----------|-------|
|     | Min         | Max  | Min       | Max   |
| A   | 2.21        | 2.38 | 0.087     | 0.094 |
| A1  | 0.89        | 1.14 | 0.035     | 0.045 |
| b   | 0.71        | 0.89 | 0.028     | 0.035 |
| b1  | 0.76        | 1.14 | 0.030     | 0.045 |
| b2  | 5.23        | 5.43 | 0.206     | 0.214 |
| c   | 0.46        | 0.58 | 0.018     | 0.023 |
| c1  | 0.46        | 0.58 | 0.018     | 0.023 |
| D   | 5.97        | 6.22 | 0.235     | 0.245 |
| E   | 6.48        | 6.73 | 0.255     | 0.265 |
| e   | 2.28 BSC    |      | 0.090 BSC |       |
| L   | 8.89        | 9.53 | 0.350     | 0.375 |
| L1  | 1.91        | 2.28 | 0.075     | 0.090 |
| L2  | 0.89        | 1.27 | 0.035     | 0.050 |
| L3  | 1.15        | 1.52 | 0.045     | 0.060 |

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